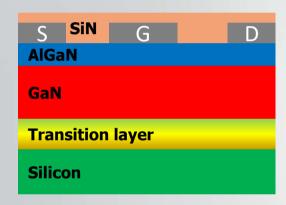


Projet HEMT 2

Début 02/11/2015 – 18 mois

Audrey Chapelle





Ref 1

6 niveaux de masque 35 étapes



Si₃N₄ deposition 50nm LPCVD

SiN

AIGaN

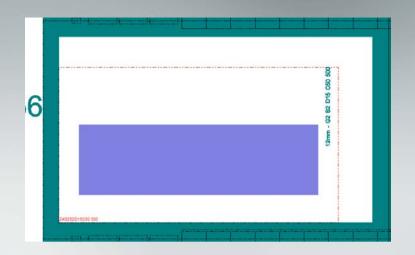
GaN

Transition layer

Silicon



Si₃N₄ deposition 50nm LPCVD Si₃N₄/AlGan/GaN RIE etch







Si₃N₄ (2) deposition





Si₃N₄ (2) deposition

Si₃N₄ etch 100nm





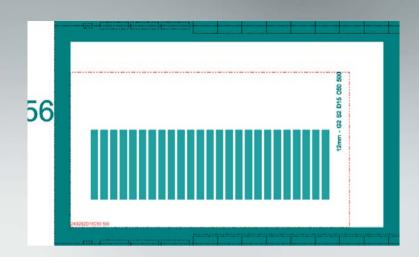
Si₃N₄ (2) deposition

Si₃N₄ etch 100nm

Ti/Al/Ni/Ti evap



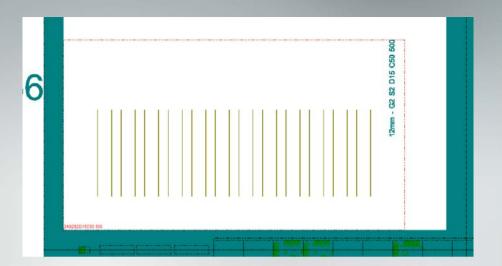
Contact source&drain Ti/Al/Ni/Ti 15/75/40/10nm







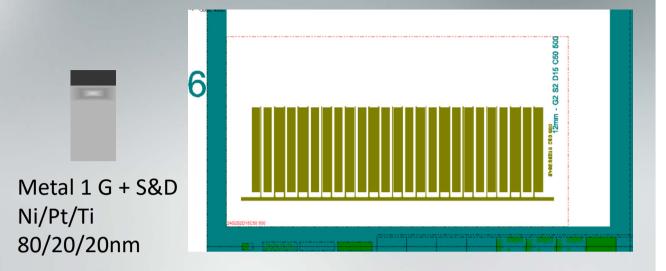
SiN etch (100nm)

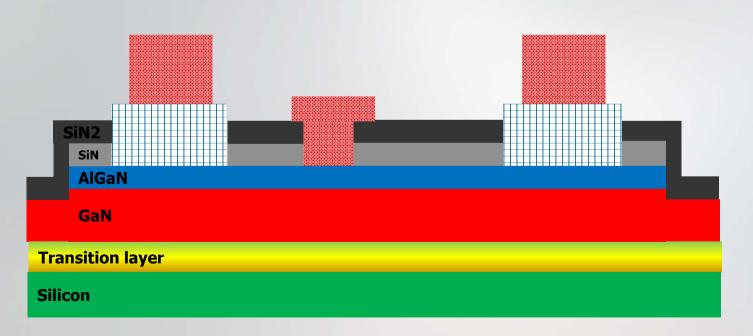






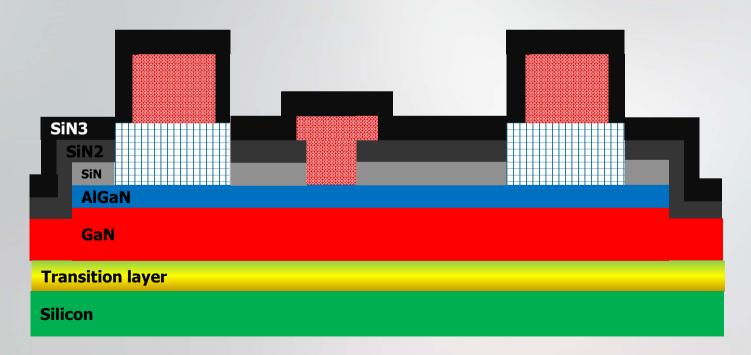
Ni/Pt/Ti evap







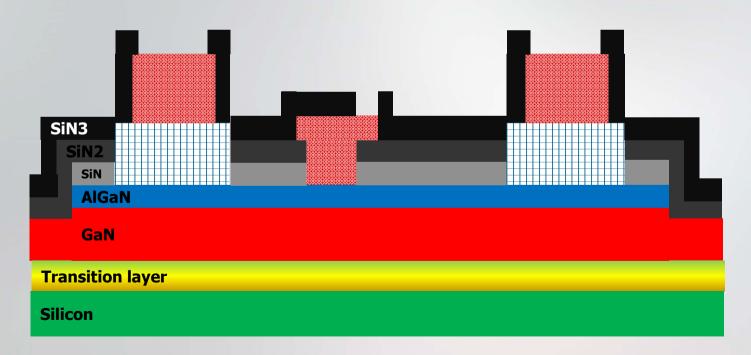
SiN (3) deposition 100nm





SiN (3) deposition 100nm SiN etch







Ti/Au evap

